

8-Channel, Programmable T/R Switch for Ultrasound

Check for Samples: [TX810](#)

FEATURES

- **Compact T/R Switch for Ultrasound**
- **Flexible Programmability**
 - **8 Bias Current Settings**
 - **8 Power/Performance Combinations**
 - **Easy Power-Up/Down control**
- **Fast Wake Up Time**
- **Dual Supply Operation**
- **Optimized Insertion Loss**

APPLICATIONS

- **Medical Ultrasound**
- **Industrial Ultrasound**

DESCRIPTION

The TX810 provides an integrated solution for a wide range of ultrasound applications. It is an 8 channel, current programmable, transmit/receive switch in a small 6mm x 6mm package.

The internal diodes limit the output voltage when high voltage transmitter signals are applied to the input. While the insertion loss of TX810 is minimized during receive mode.

Unlike conventional T/R switches, the TX810 contains a 3-bit interface used to program bias current from 7mA to 0mA for different performance and power requirements. When the TX810 bias current is set as 0mA (i.e., high-impedance mode), the device is configured as power-down mode. In the high-impedance mode, TX810 does not add additional load to high-voltage transmitters. In addition, the device can wake up from power-down mode in less than 1μs. With these advanced programmability features, significant power saving can be achieved in systems.

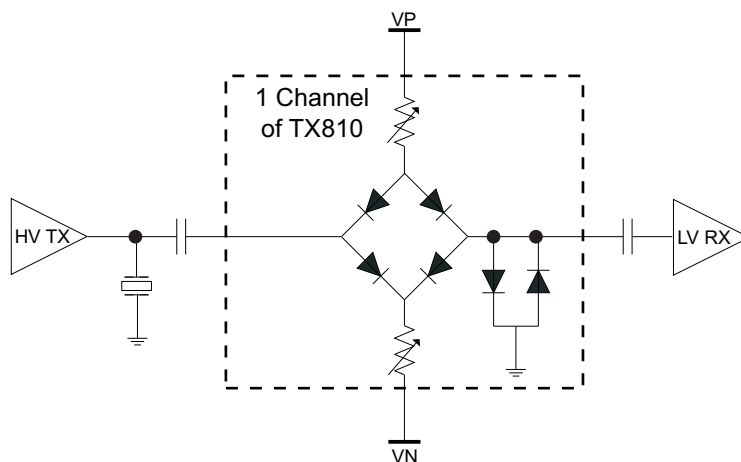


Figure 1. Block Diagram of TX810



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These devices have limited built-in ESD protection. The leads should be shorted together or the device placed in conductive foam during storage or handling to prevent electrostatic damage to the MOS gates.

ORDERING INFORMATION⁽¹⁾

PACKAGED DEVICES	PACKAGE TYPE	TRANSPORT MEDIA, QUANTITY	OPERATING TEMPERATURE RANGE
TX810IRHHT	S-PVQFN-N36	Tape and Reel, 250	0~70°C
TX810IRHHR		Tape and Reel, 2500	

- (1) For the most current package and ordering information, see the Package Option Addendum at the end of this document, or see the TI website at www.ti.com.

ABSOLUTE MAXIMUM RATINGS⁽¹⁾

over operating free-air temperature range (unless otherwise noted)

	VALUE	UNIT
Supply Voltage, VD	-0.3 ~ +6	V
Supply Voltage, VP	-0.3 ~ +6	V
Supply Voltage, VN	-6 ~ +0.3	V
Supply Voltage, VB	-0.3 ~ +6	V
Input AC voltage, INn	±100	V
Input at Vsub	-6 ~ +0.3	V
Output current, IO	15	mA
Maximum junction temperature, continuous operation, long term reliability ⁽²⁾ TJ	125°C	
Storage temperature range, Tstg	-55°C to 150°C	
ESD ratings	HBM	500
	CDM	750
	MM	200

- (1) Stresses above those listed under absolute maximum ratings may cause permanent damage to the device. These are stress ratings only and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute maximum rated conditions for extended periods may degrade device reliability.
- (2) The absolute maximum junction temperature for continuous operation is limited by the package constraints. Operation above this temperature may result in reduced reliability and/or lifetime of the device.

THERMAL INFORMATION

THERMAL METRIC ⁽¹⁾ (OLFM Airflow Assumed)		TX810	UNITS
		RHH	
		36 PINS	
θ_{JA}	Junction-to-ambient thermal resistance ⁽²⁾	29.7	°C/W
$\theta_{JC(top)}$	Junction-to-case(top) thermal resistance ⁽³⁾	27	
θ_{JB}	Junction-to-board thermal resistance ⁽⁴⁾	7.2	
ψ_{JT}	Junction-to-top characterization parameter ⁽⁵⁾	0.1	
ψ_{JB}	Junction-to-board characterization parameter ⁽⁶⁾	7.2	

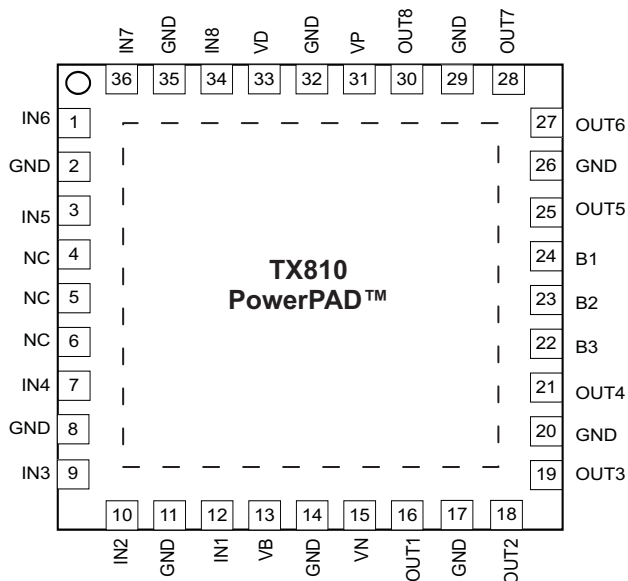
- (1) For more information about traditional and new thermal metrics, see the *IC Package Thermal Metrics* application report, [SPRA953](#).
- (2) The junction-to-ambient thermal resistance under natural convection is obtained in a simulation on a JEDEC-standard, High-K board, as specified in JESD51-7, in an environment described in JESD51-2a.
- (3) The junction-to-case(top) thermal resistance is obtained by simulating a cold plate test on the package top. No specific JEDEC-standard test exists, but a close description can be found in the ANSI SEMI standard G30-88.
- (4) The junction-to-board thermal resistance is obtained by simulating in an environment with a ring cold plate fixture to control the PCB temperature, as described in JESD51-8.
- (5) The junction-to-top characterization parameter, ψ_{JT} , estimates the junction temperature of a device in a real system and is extracted from the simulation data for obtaining θ_{JA} , using a procedure described in JESD51-2a (sections 6 and 7).
- (6) The junction-to-board characterization parameter, ψ_{JB} , estimates the junction temperature of a device in a real system and is extracted from the simulation data for obtaining θ_{JA} , using a procedure described in JESD51-2a (sections 6 and 7).

DEVICE INFORMATION

PIN FUNCTIONS

PIN		DESCRIPTION
NUMBER	NAME	
1, 3, 7, 9, 10, 12, 34, 36	IN _n	Inputs for Channel n
16, 18, 19, 21, 25, 27, 28, 30	OUT _n	Outputs for Channel n
33	VD	Logic Supply Voltage; +2.5 V to +5 V; bypass to ground with 0.1 μ F and 10 μ F capacitors
31	VP	Positive Supply Voltage; +5 V; bypass to ground with 0.1 μ F and 10 μ F capacitors
15	VN	Negative Supply Voltage; –5 V; bypass to ground with 0.1 μ F and 10 μ F capacitors
13	VB	Bias voltage; connect to 0 V (GND) for \pm 5 V operation
2, 8, 11, 14, 17, 20, 26, 29, 32, 35	GND	Ground
24	B1	Bit 1; Current program bit
23	B2	Bit 2; Current program bit
22	B3	Bit 3; Current program bit
4, 5, 6	NC	No internal connection.
0	V _{sub}	PowerPAD™ of the package. –5 V to 0 V for \pm 5 V operation. The thermal pad is needed for thermal dissipation.

PQFN (RHH) Package
6 × 6mm, 0.5mm Pitch
(Top View)



ELECTRICAL CHARACTERISTICS

All Specifications at $T_A = 25^\circ\text{C}$, $V_P = 5\text{V}$, $V_N = -5\text{V}$, $V_B = 0\text{V}$, $V_{\text{sub}} = -5\text{V}$, $R_{\text{LOAD}} = 400\Omega$; $f = 5\text{MHz}$, $B3B2B1 = 111$, $V_{\text{IN}} = 0.25V_{\text{PP}}$, unless otherwise noted. Test Level: A: Final tester limits; B: bench evaluation/simulation; C: Simulation

PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT	Test Level
DC POWER SPECIFICATIONS						
Positive Supply V_P			5		V	B
Negative Supply V_N			-5			
Quiescent current, V_P , V_N	No Signal			50	μA	A
Substrate Voltage, V_{SUB}	PowerPAD™		V_N	0	V	B
Digital Supply, V_D		2.5	5		V	B
Quiescent current, V_D	No Signal			50	μA	A
Bias current, V_P , V_N path	B3B2B1 = 001	1.25	1	0.75	mA/CH	A
Bias current, V_P , V_N path	B3B2B1 = 111	5.95	7	8.05	mA/CH	A
Leakage Current	Any output; B3B2B1 = 000; No Input			0.5	μA	A
LOGIC INPUTS						
Logic High Input Voltage; V_{IH}		2		V_D	V	A
Logic High Input Current; I_{IH}				20	μA	A
Logic Low Input Voltage; V_{IL}		0		0.4	V	A
Logic Low Input Current; I_{IL} Input				20	μA	A
Capacitance, C_{IN}			5		pF	C
POWER DISSIPATION						
Power-Down Dissipation	B3B2B1 = 000; no signal			200	μW	A
Total Power Dissipation	B3B2B1 = 001; no signal		80	92	mW	A
	B3B2B1 = 111; no signal		560	644	mW	A
AC SPECIFICATIONS						
Input Amplitude, V_{IN}	1 μs positive and negative pulse applied separately at PRF = 10 kHz	-90		90	V	A
	CW mode (continuous wave)	-10		10	V	B
Insertion loss, I_L	B3B2B1 = 111		-0.9	-1.8	dB	A
	B3B2B1 = 100		-1.1	-1.8	dB	A
	B3B2B1 = 001		-1.3	-2	dB	A
	B3B2B1 = 111, $R_{\text{LOAD}} = 50\Omega$		-4.1		dB	B
	B3B2B1 = 001, $R_{\text{LOAD}} = 50\Omega$		-7		dB	B
Channel to channel I_L matching	B3B2B1 = 111		0.06		dB	B
Insertion Loss, I_L	B3B2B1 = 111, at 20MHz		-0.9		dB	B
Equivalent Resistance, R_{ON}	B3B2B1 = 111, $R_{\text{LOAD}} = 50\Omega$		30		Ω	B
	B3B2B1 = 001, $R_{\text{LOAD}} = 50\Omega$		62		Ω	B
	B3B2B1 = 111		44		Ω	B
	B3B2B1 = 001		67		Ω	B
-3dB Bandwidth, BW	B3B2B1 = 111		140		MHz	B
	B3B2B1 = 100		115		MHz	B
	B3B2B1 = 001		65		MHz	B
2nd Harmonic Distortion, HD2, 5MHz	B3B2B1 = 111, $V_{\text{IN}} = 0.5V_{\text{PP}}$ 5MHz		-74		dBc	B
	B3B2B1 = 100, $V_{\text{IN}} = 0.5V_{\text{PP}}$ 5MHz		-74		dBc	B
	B3B2B1 = 001, $V_{\text{IN}} = 0.5V_{\text{PP}}$ 5MHz		-73		dBc	B

ELECTRICAL CHARACTERISTICS (continued)

All Specifications at $T_A = 25^\circ\text{C}$, $V_P = 5\text{V}$, $V_N = -5\text{V}$, $V_B = 0\text{V}$, $V_{\text{sub}} = -5\text{V}$, $R_{\text{LOAD}} = 400\Omega$; $f = 5\text{MHz}$, $B3B2B1 = 111$, $V_{\text{IN}} = 0.25V_{\text{PP}}$, unless otherwise noted. Test Level: A: Final tester limits; B: bench evaluation/simulation; C: Simulation

PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT	Test Level
2nd Harmonic Distortion, HD2, 10MHz	B3B2B1 = 111, $V_{\text{IN}} = 0.5 V_{\text{PP}}$ 10MHz		-78		dBc	B
	B3B2B1 = 100, $V_{\text{IN}} = 0.5 V_{\text{PP}}$ 10MHz		-77		dBc	B
	B3B2B1 = 001, $V_{\text{IN}} = 0.5 V_{\text{PP}}$ 10MHz		-74		dBc	B
Cross-talk, Xtalk	B3B2B1 = 111 at 10MHz		-70		dBc	B
	B3B2B1 = 100 at 10MHz		-69		dBc	B
	B3B2B1 = 001 at 10MHz		-61		dBc	B
3rd order Intermodulation, IMD3 ⁽¹⁾	B3B2B1 = 111		-68		dBc	B
	B3B2B1 = 100		-65		dBc	B
	B3B2B1 = 001		-50		dBc	B
Power Supply Modulation Ratio, PSMR ⁽²⁾	B3B2B1 = 111		-76		dBc	B
	B3B2B1 = 100		-76		dBc	B
	B3B2B1 = 001		-76		dBc	B
Power Supply Rejection Ratio, PSRR	B3B2B1 = 111, 1KHz and 1MHz		-64		dBc	B
Input Referred Noise, IRN	B3B2B1 = 111		0.91		nV/rtHz	B
	B3B2B1 = 100		1.05		nV/rtHz	B
	B3B2B1 = 001		1.12		nV/rtHz	B
Recovery Time 140 V_{PP} IN, $V_{\text{OUT}} < 20mV_{\text{PP}}$	B3B2B1 = 111		1		μs	B
	B3B2B1 = 100		0.5		μs	B
	B3B2B1 = 001		0.3		μs	B
Turn-on Delay Time ⁽³⁾ , $t_{\text{EN_ON}}$	B3B2B1 = 000→111		0.6		μs	B
	B3B2B1 = 000→100		0.5		μs	B
	B3B2B1 = 000→001		0.5		μs	B
Turn-off Delay Time ⁽³⁾ , $t_{\text{EN_OFF}}$	B3B2B1 = 111→000		2.4		μs	B
	B3B2B1 = 100→000		2.7		μs	B
	B3B2B1 = 001→000		2.2		μs	B
Bias Current Switching Time	B3B2B1 = 001→111		0.7		μs	B
Propagation Delay Time ⁽³⁾ , t_{DELAY}	B3B2B1 = 111		1.3		ns	B
	B3B2B1 = 100		1.6		ns	B
	B3B2B1 = 001		1.7		ns	B
Clamp Voltage, excludes overshoot	B3B2B1 = 111		1.9		V_{PP}	B
	B3B2B1 = 001		1.7		V_{PP}	B
	B3B2B1 = 000		1.4		V_{PP}	B

(1) 5MHz $1V_{\text{PP}}$, and 5.01MHz $0.5V_{\text{PP}}$ input.

(2) PSMR is defined as the ratio between carrier 5MHz and side band signals with 1KHz and 1MHz $50mV_{\text{PP}}$ Noise applied on supply pins.

(3) See the timing diagram show in [Figure 2](#).

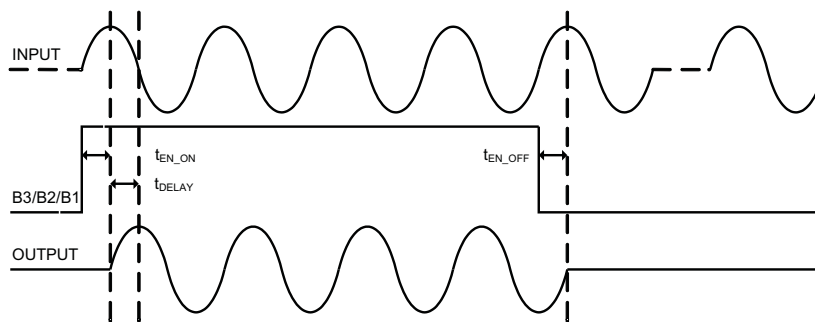


Figure 2. Timing Diagram

TYPICAL CHARACTERISTICS

All Specifications at $T_A = 25^\circ\text{C}$, $V_P = 5\text{V}$, $V_N = -5\text{V}$, $V_B = 0\text{V}$, $V_{SUB} = -5\text{V}$, $R_{IN} = 75\Omega$, $R_{LOAD} = 400\Omega$; $f = 5\text{MHz}$, $B3B2B1=111$, $V_{IN} = 0.25\text{V}_{pp}$, unless otherwise noted.

A typical bench setup is shown in Figure 3.

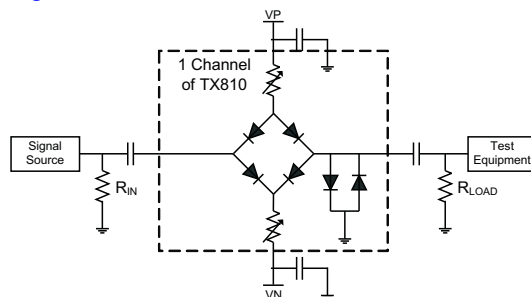


Figure 3. Typical Test Setup

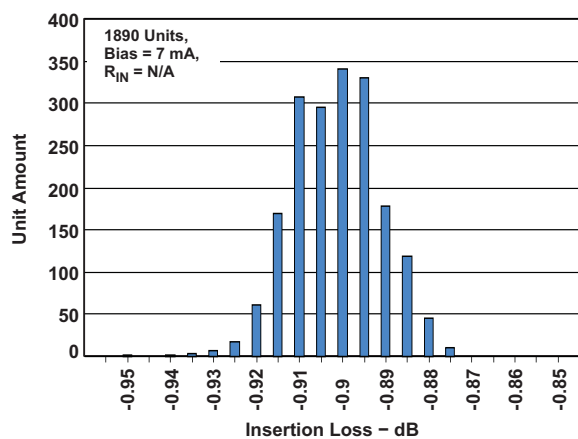
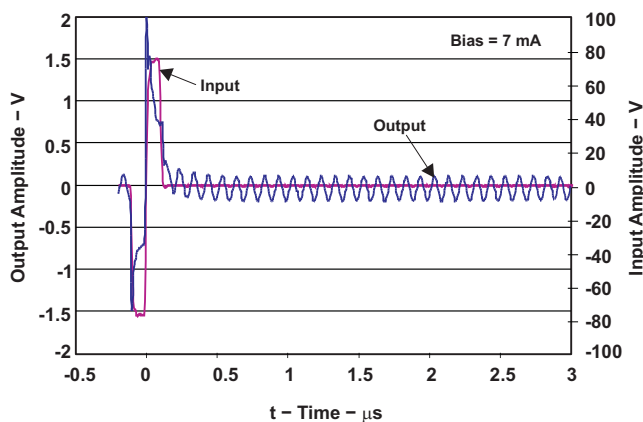


Figure 4. Insertion Loss Distribution

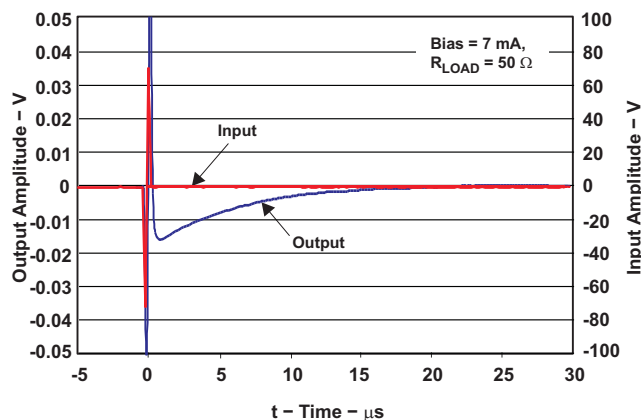


AC coupling is used between High voltage pulser and TX810. The input signal is a combination of 0.25Vpp signal followed by a 1-cycle 140Vpp pulse

Figure 5. Recovery Time With Small Input Signal

TYPICAL CHARACTERISTICS (continued)

All Specifications at $T_A = 25^\circ\text{C}$, $V_P = 5\text{V}$, $V_N = -5\text{V}$, $V_B = 0\text{V}$, $V_{\text{SUB}} = -5\text{V}$, $R_{\text{IN}} = 75\Omega$, $R_{\text{LOAD}} = 400\Omega$;
 $f = 5\text{MHz}$, $B3B2B1=111$, $V_{\text{IN}} = 0.25V_{\text{PP}}$, unless otherwise noted.



AC coupling is used between High voltage pulser and TX810. The input signal is a 1-cycle 140Vpp pulse

Figure 6. Recovery Time Without Signal

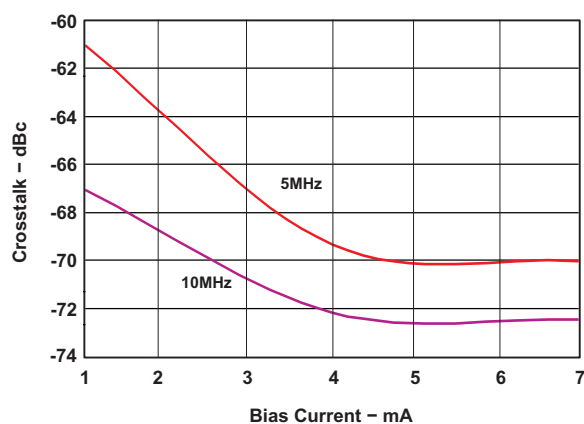


Figure 7. Cross-talk vs. Bias Currents vs. Frequency

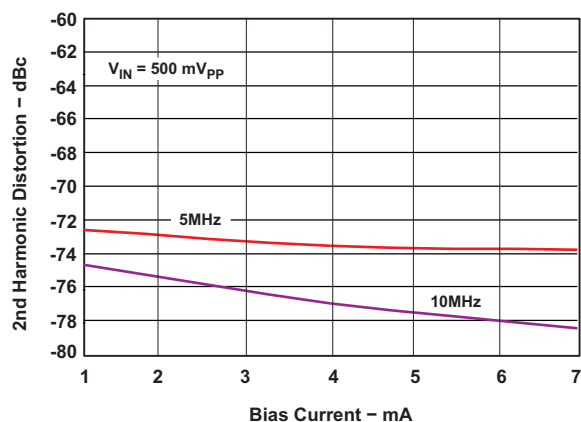


Figure 8. HD2 vs. Bias Current vs. Frequency

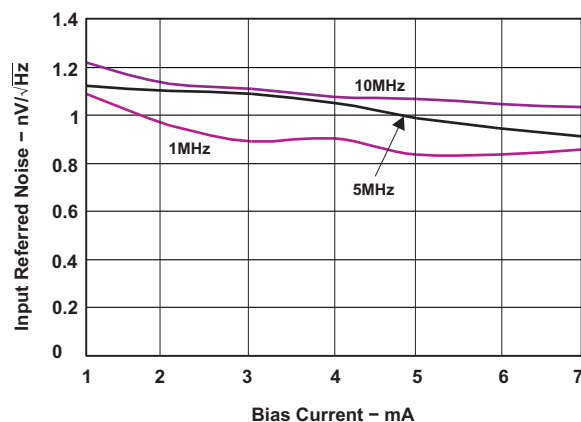


Figure 9. Input Referred Noise vs. Bias Current vs. Frequency

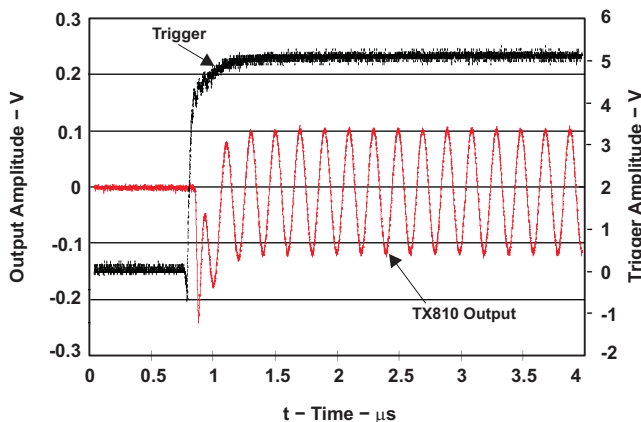


Figure 10. Power On Response Time (0mA to 7mA)

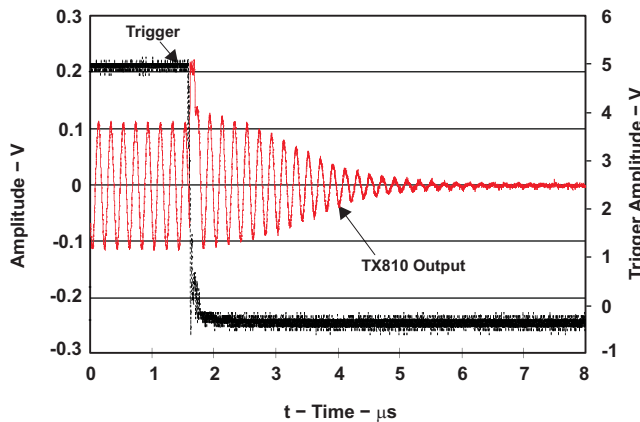


Figure 11. Power Down Response Time (7mA to 0mA)

TYPICAL CHARACTERISTICS (continued)

All Specifications at $T_A = 25^\circ\text{C}$, $V_P = 5\text{V}$, $V_N = -5\text{V}$, $V_B = 0\text{V}$, $V_{\text{SUB}} = -5\text{V}$, $R_{\text{IN}} = 75\Omega$, $R_{\text{LOAD}} = 400\Omega$; $f = 5\text{MHz}$, B3B2B1=111, $V_{\text{IN}} = 0.25V_{\text{PP}}$, unless otherwise noted.

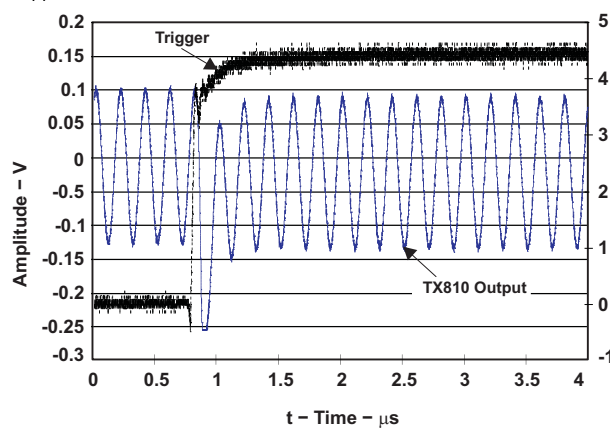


Figure 12. Bias Current Adjustment Response Time (1mA to 7mA)

THEORY OF OPERATION

A typical ultrasound block diagram is shown in [Figure 13](#).

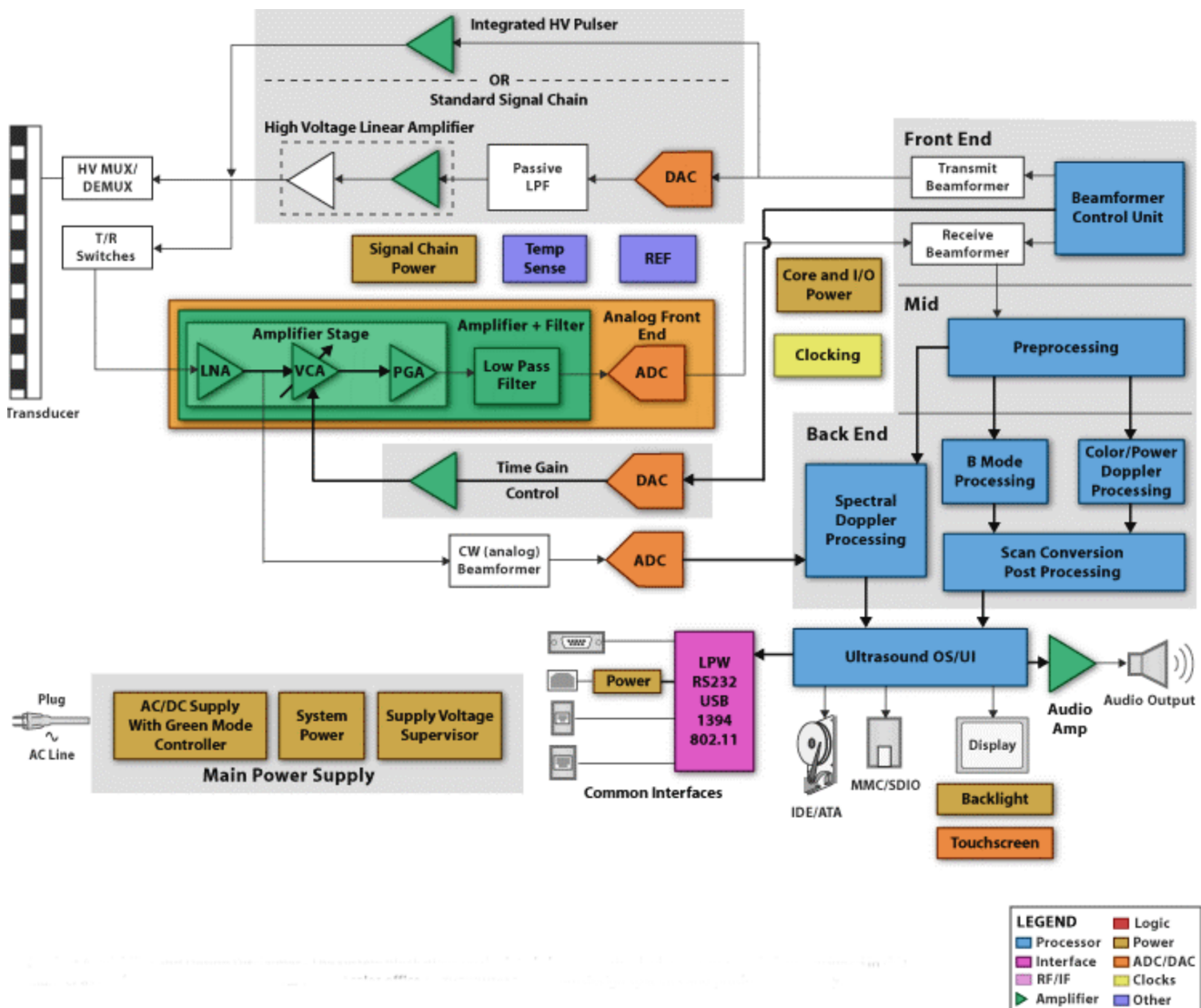


Figure 13. Ultrasound System Block Diagram

A transducer is excited by high voltage pulsers. It converts the electrical energy to mechanical energy. After each excitation, the transducer sends out ultrasonic wave to medium. Partial ultrasonic wave gets reflected by inhomogeneous medium and received by the transducer again, i.e. echo signal. Thus, the transducer is a duplex device on which both high voltage and low voltage signals exist. The transducer can not be connected to amplifier stages directly; otherwise, the high voltage signal can permanently destroy amplifiers. The TX810, i.e. T/R switches, is sitting between integrated HV pulser and low noise amplifier (LNA). The main function of TX810 is to isolate the LNA from high-voltage transmitter. TX810 limits the high voltage pulse and let echo signals reaching amplifier. Therefore, an ideal T/R switch should completely block high voltage signals and maintain all information from echoes.

The detail architecture of the TX810 is listed in [Figure 14](#).

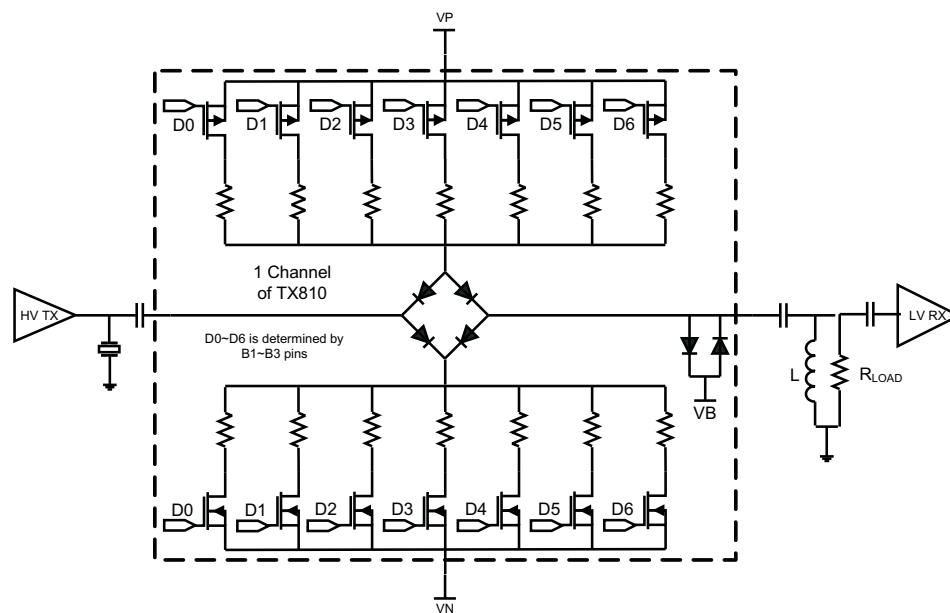


Figure 14. TX810 Block Diagram

TX810 includes four parts: Diode Bridge, bias network, clamp diodes, and logic controller. A decoder is used to convert 3-bit logic (B1 to B3) input to 7 control signals (D0 to D6) for 7 MOSFET switches. +2.5V to +5V logic input is level shifted internally to drive the switches. The bias current of the bridge diode is adjusted proportionally by these switches. When all switches are on, the bias current is 7mA. Each bit difference will adjust the bias current approximately 1mA. When all switches are off, the TX810 enters the power down mode. Comparing to discrete T/R switches, TX810 can be shut down and turned on quickly as shown in the typical characteristics plots. Considering the low duty cycle of ultrasound imaging, significant power saving can be achieved.

All 6 diodes are high-voltage Schottky diodes to achieve fast recovery time. Following the bridge, a pair of back-to-back diode limits the output voltage of TX810 to about 2Vpp. Different power/performance combination can be selected by users. The TX810 is specified to operate at $\pm 5V$ and VB is biased at 0V. The characteristics of the T/R switch are mainly determined by bias currents. Lower power can be achieved with lower supply voltages. Also, Table 1 shows the relationship among bias current, insertion loss, input noise, power consumption and equivalent resistance.

Table 1. Bias current vs Performance

Test Conditions: VP = 5V, VN = -5V; VB = 0V; R _{LOAD} = 50Ω							
B3	B2	B1	I (mA)	I _L (dB)	IRN (nV/rtHz)	R _{ON} (Ω)	Power (mW/CH)
0	0	0	0	N/A	N/A	High Impedance	0
0	0	1	1	-7	1.12	62	10
0	1	0	2	-5.6	1.10	45	20
0	1	1	3	-5	1.09	39	30
1	0	0	4	-4.6	1.05	35	40
1	0	1	5	-4.4	0.99	33	50
1	1	0	6	-4.2	0.95	31	60
1	1	1	7	-4.1	0.91	30	70

APPLICATION INFORMATION

Similar to discrete T/R switch solutions, external components can be used to optimize system performance. Inductor L and resistor R_{LOAD} before the low voltage receiver amplifier (LVRx) can improve overload recovery time and reduce reflection. The L acts as a high pass filter thus overshoot or recovery response spikes can be suppressed to minimal. The L and R_{LOAD} terminate the entire signal path and can reduce reflection; therefore axial resolution in ultrasound image might be improved. However, the combined impedance of L and R_{LOAD} may affect the system sensitivity. The insertion loss of T/R switch is determined by the input impedance of receiver amplifier and R_{ON} of the TX810. L also creates a DC path for any offset caused by mismatching. The inductor can be as low as 10s μ H to suppress low frequency signals from transmitter, transducer, multiplexer, and TX810. The optimization of L and R_{LOAD} is always an important topic for system designers. AC coupling are typically used between transmitter and T/R switch or T/R switch and amplifier. Thus amplifiers with DC biased inputs will not interference with T/R switch.

One challenge for integrating multiple channel circuits on a small package is how to reduce cross talk. In ultrasound systems, acoustic cross talk from adjacent transducer elements is a dominant source. The cross talk from transducer elements is in a range of -30 to -35dBc for array transducers. Circuit cross talk is usually at least 20dB better than the transducer cross talk. The special considerations were implemented in both TX810 design and layout. The cross talk among TX810 channels is reduced to below -60 dBc as show in the specification table.

In ultrasound Doppler applications, modulation effect in system can influence image quality and sensitivity. Ultrasound system is a complex mixed-signal system with all kinds of digital and analog circuits. Digital signals and clock signals can contaminate analog signals on system level or on chip level. Nonlinear components, such as transistors and diodes, can modulate noise and contaminate signals. In Doppler applications, the Doppler signal frequency could range from 20Hz to >50KHz. Meanwhile, multiple system clocks are also in this range, such as frame clock, image line clock, and etc. These noise signals could enter chip through ground and power supply pins. It is important to study the power supply modulation ratio (PSMR) at chip level. Noise signal with certain frequency and amplitude can be applied on supply pins. Side band signals could be found if modulation effect exists. The PSMR is expressed as an amplitude ratio between carrier and side band signals. Beside PSMR, 3rd order intermodulation ratio (IMD3) is a standard specification for mixed-signal ICs. Users can use IMD3 to estimate the potential artifact Doppler mirror signals. Both specs can be found in the specification table.

The schematic of the basic connection for TX810 is shown in [Figure 15](#). Optional inductors and resistors can be used at TX810 outputs depending on transducer characteristics as discussed above. Standard decoupling capacitors 0.1 μ F should be placed close to power supply pins. The pin out of TX810 is optimized for PCB layout. All signals are going from left to right straightly.

TX810

SLLS996A – SEPTEMBER 2009 – REVISED APRIL 2010

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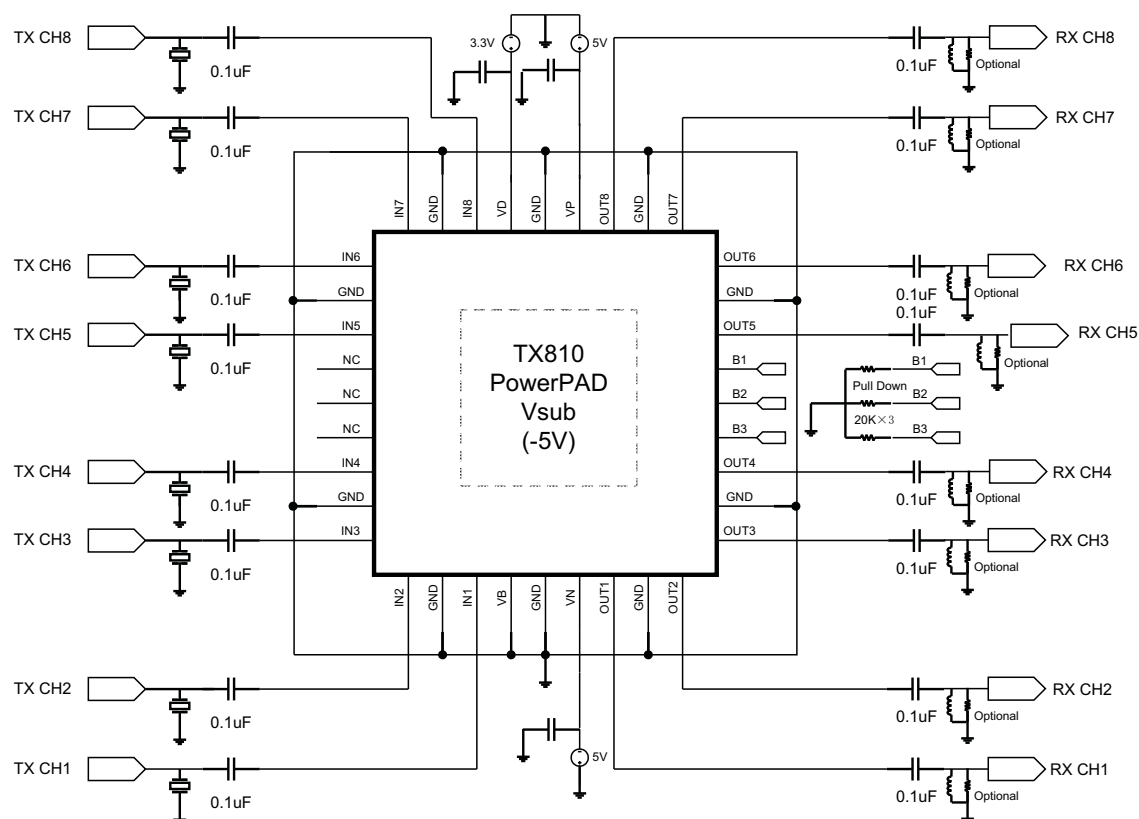


Figure 15. Schematic of TX810

REVISION HISTORY

Changes from Original (September 2009) to Revision A

Page

- Changed From: Product Preview To: Production. The Product Preview was a two page data sheet containing the front page and the pin out section 1

PACKAGING INFORMATION

Orderable part number	Status (1)	Material type (2)	Package Pins	Package qty Carrier	RoHS (3)	Lead finish/ Ball material (4)	MSL rating/ Peak reflow (5)	Op temp (°C)	Part marking (6)
TX810IRHHT	Active	Production	VQFN (RHH) 36	250 SMALL T&R	Yes	NIPDAU	Level-2-260C-1 YEAR	0 to 70	TX810
TX810IRHHT.A	Active	Production	VQFN (RHH) 36	250 SMALL T&R	Yes	NIPDAU	Level-2-260C-1 YEAR	0 to 70	TX810
TX810IRHHTG4	Active	Production	VQFN (RHH) 36	250 SMALL T&R	Yes	NIPDAU	Level-2-260C-1 YEAR	0 to 70	TX810
TX810IRHHTG4.A	Active	Production	VQFN (RHH) 36	250 SMALL T&R	Yes	NIPDAU	Level-2-260C-1 YEAR	0 to 70	TX810

⁽¹⁾ **Status:** For more details on status, see our [product life cycle](#).

⁽²⁾ **Material type:** When designated, preproduction parts are prototypes/experimental devices, and are not yet approved or released for full production. Testing and final process, including without limitation quality assurance, reliability performance testing, and/or process qualification, may not yet be complete, and this item is subject to further changes or possible discontinuation. If available for ordering, purchases will be subject to an additional waiver at checkout, and are intended for early internal evaluation purposes only. These items are sold without warranties of any kind.

⁽³⁾ **RoHS values:** Yes, No, RoHS Exempt. See the [TI RoHS Statement](#) for additional information and value definition.

⁽⁴⁾ **Lead finish/Ball material:** Parts may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

⁽⁵⁾ **MSL rating/Peak reflow:** The moisture sensitivity level ratings and peak solder (reflow) temperatures. In the event that a part has multiple moisture sensitivity ratings, only the lowest level per JEDEC standards is shown. Refer to the shipping label for the actual reflow temperature that will be used to mount the part to the printed circuit board.

⁽⁶⁾ **Part marking:** There may be an additional marking, which relates to the logo, the lot trace code information, or the environmental category of the part.

Multiple part markings will be inside parentheses. Only one part marking contained in parentheses and separated by a "~" will appear on a part. If a line is indented then it is a continuation of the previous line and the two combined represent the entire part marking for that device.

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GENERIC PACKAGE VIEW

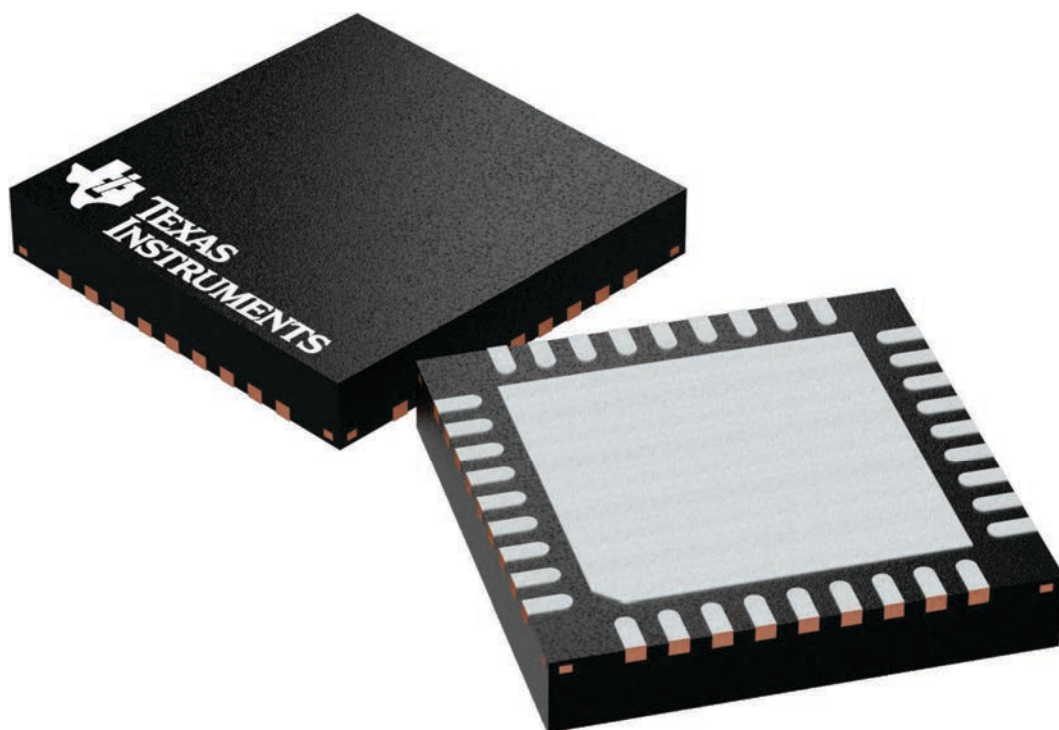
RHH 36

VQFN - 1 mm max height

6 x 6, 0.5 mm pitch

PLASTIC QUAD FLATPACK - NO LEAD

This image is a representation of the package family, actual package may vary.
Refer to the product data sheet for package details.



4225440/A

VQFN - 1 mm max height

The drawing illustrates the mechanical specifications of a 24-pin Quad Flat Pack (QFP) package. It includes three main views: a top view, a side view, and a detail view of the lead profile.

- Top View:** Shows the square body of the package with a central square cavity. The overall width and height are 6.1 mm (5.9 mm minimum). A "PIN 1 INDEX AREA" is marked in the top-left corner. Pin 1 is located at the bottom-left corner, with its ID (inner diameter) specified as 0.5 mm. The package is symmetrical (SYMM) about both horizontal and vertical centerlines. Dimensions for the central cavity include a width of 4.1 ± 0.1 mm and a height of 3.7 mm. The distance from the center to the pin 1 ID is 1.0 mm. The distance from the center to the top edge is 1.8 mm, and from the center to the bottom edge is 2.8 mm. The distance from the center to the left edge is 1.0 mm, and from the center to the right edge is 1.9 mm. The distance from the center to the top-left corner is 1.0 mm. The distance from the center to the bottom-left corner is 1.0 mm. The distance from the center to the top-right corner is 1.0 mm, and from the center to the bottom-right corner is 1.0 mm. The distance from the center to the top edge is 1.8 mm, and from the center to the bottom edge is 2.8 mm. The distance from the center to the left edge is 1.0 mm, and from the center to the right edge is 1.9 mm. The distance from the center to the top-left corner is 1.0 mm, and from the center to the bottom-left corner is 1.0 mm. The distance from the center to the top-right corner is 1.0 mm, and from the center to the bottom-right corner is 1.0 mm.
- Side View:** Shows the package height and the "SEATING PLANE". The total height is 1.0 mm (0.8 mm minimum). The distance from the seating plane to the top of the package is 0.05 mm (0.00 mm minimum). The distance from the seating plane to the top of the package is 0.05 mm (0.00 mm minimum). The distance from the seating plane to the top of the package is 0.05 mm (0.00 mm minimum).
- Detail View:** Shows the profile of a single lead. The lead height is 0.08 mm (0.05 mm minimum). The lead width is 0.2 mm (typical). The lead thickness is 0.05 mm (0.03 mm minimum). The lead width is 0.2 mm (typical). The lead thickness is 0.05 mm (0.03 mm minimum). The lead width is 0.2 mm (typical). The lead thickness is 0.05 mm (0.03 mm minimum).

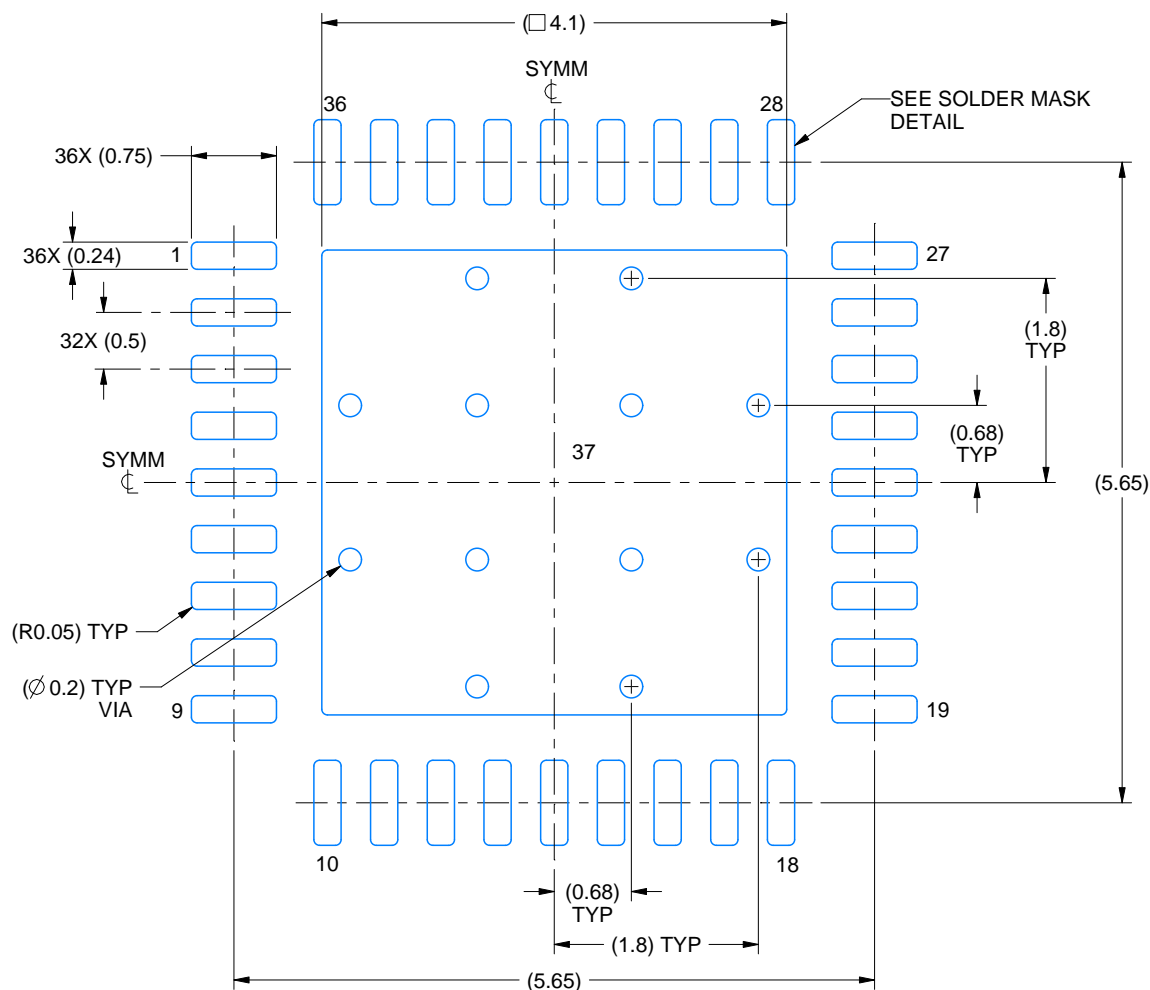
1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
2. This drawing is subject to change without notice.
3. The package thermal pad must be soldered to the printed circuit board for thermal and mechanical performance.

EXAMPLE BOARD LAYOUT

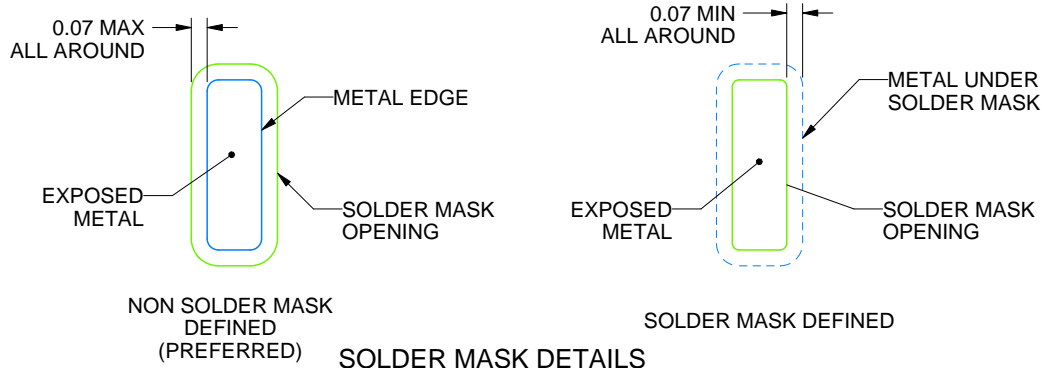
RHH0036B

VQFN - 1 mm max height

PLASTIC QUAD FLATPACK - NO LEAD



LAND PATTERN EXAMPLE
EXPOSED METAL SHOWN
SCALE: 15X



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NOTES: (continued)

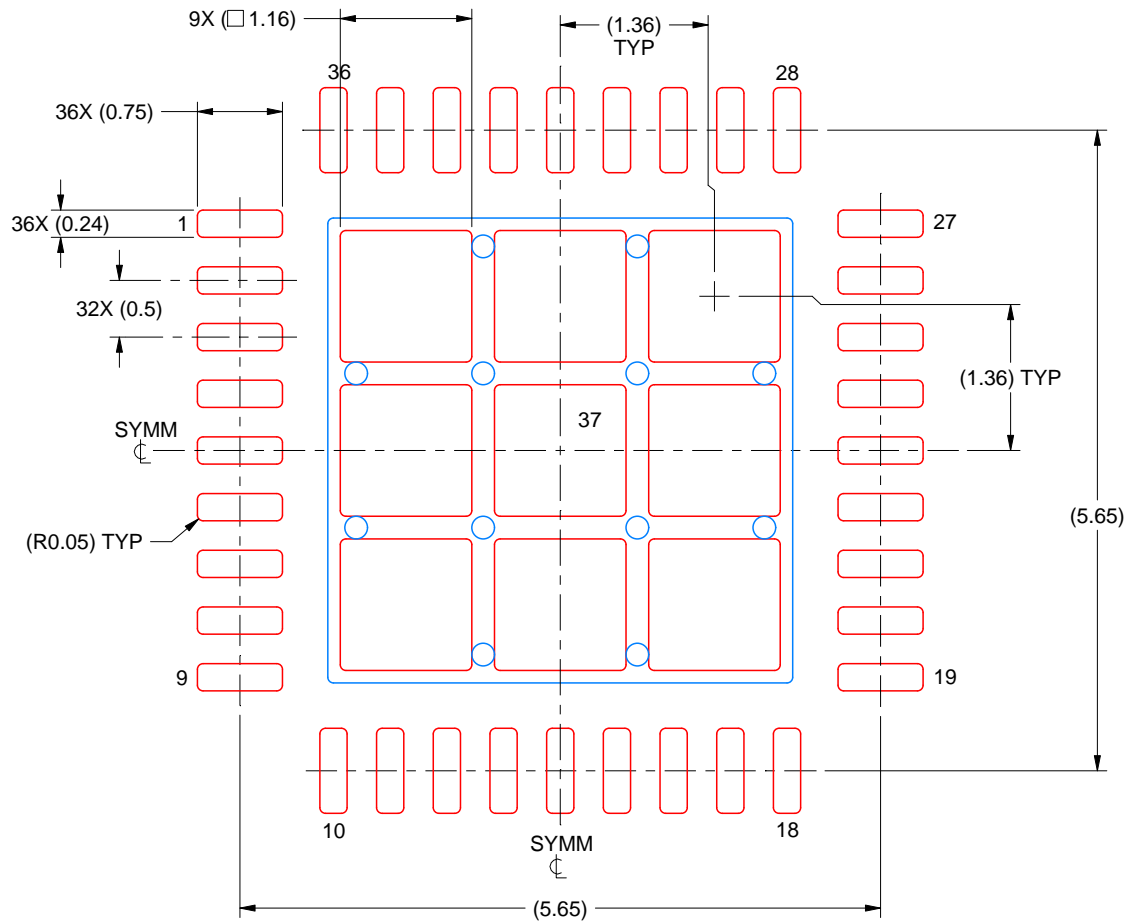
- This package is designed to be soldered to a thermal pad on the board. For more information, see Texas Instruments literature number SLUA271 (www.ti.com/lit/sluea271).
- Vias are optional depending on application, refer to device data sheet. If any vias are implemented, refer to their locations shown on this view. It is recommended that vias under paste be filled, plugged or tented.

EXAMPLE STENCIL DESIGN

RHH0036B

VQFN - 1 mm max height

PLASTIC QUAD FLATPACK - NO LEAD



SOLDER PASTE EXAMPLE
BASED ON 0.125 MM THICK STENCIL
SCALE: 15X

EXPOSED PAD 37
72% PRINTED SOLDER COVERAGE BY AREA UNDER PACKAGE

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NOTES: (continued)

6. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.

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